

<b>Notice of References Cited</b>	Application/Control No. 10/064,012	Applicant(s)/Patent Under Reexamination ABBONDANZIO ET AL.	
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#### NON-PATENT DOCUMENTS

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	V	Rietze et al, Nov. 20/2001, Pub. No. 2003/0097487
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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